

## **< HVIGBT MODULE >**

# CMH1200DC-34S

## HIGH POWER SWITCHING USE INSULATED TYPE

SiC Hybrid HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Module

**CMH1200DC-34S**



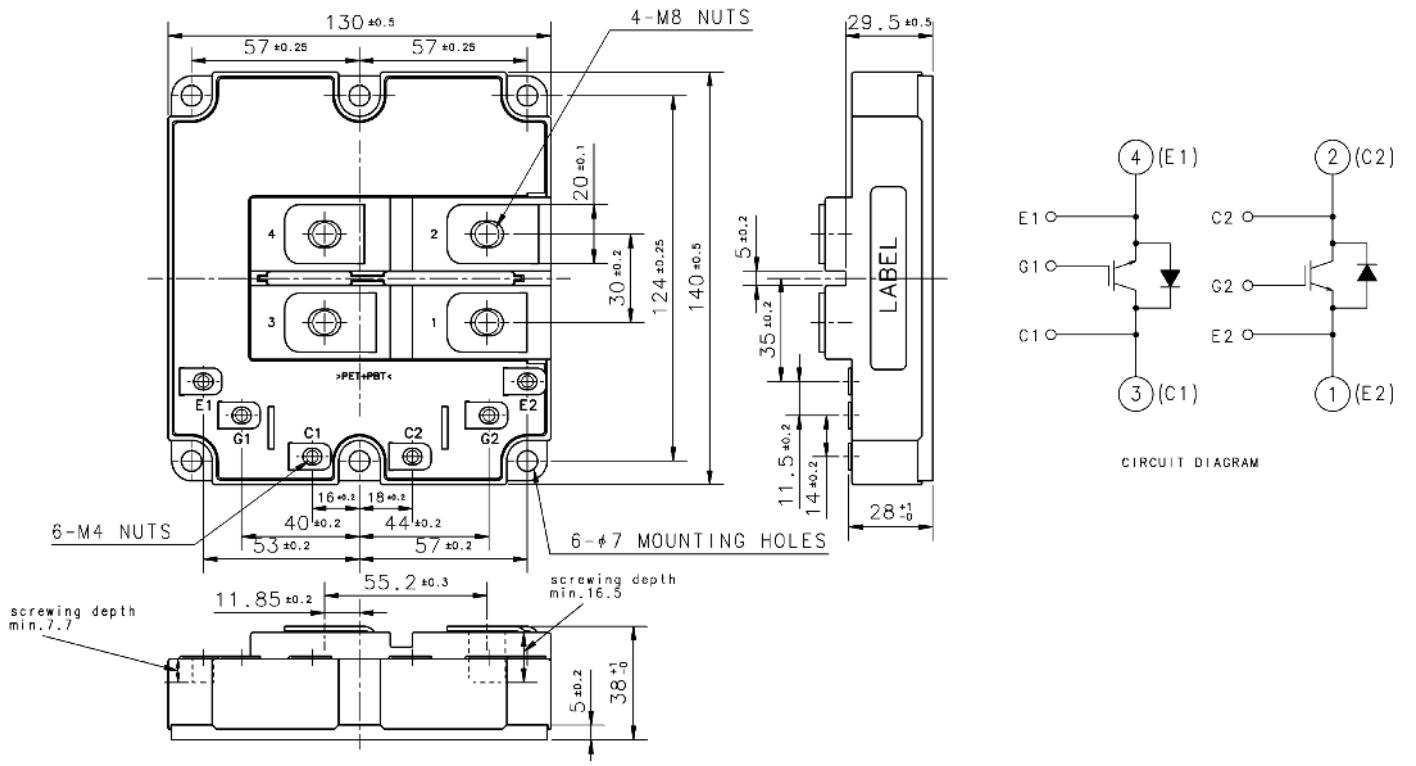
- $I_C$ ..... 1200A
- $V_{CES}$ ..... 1700V
- 2-element in a Pack
- Insulated Type
- CSTBT™
- SiC Schottky-Barrier Diode
- AlSiC Baseplate

## APPLICATION

## Traction drives, High Reliability Converters / Inverters, DC choppers

## OUTLINE DRAWING & CIRCUIT DIAGRAM

### Dimensions in mm



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**MAXIMUM RATINGS**

Symbol	Item	Conditions	Ratings	Unit
$V_{CES}$	Collector-emitter voltage	$V_{GE} = 0V$	1700	V
$V_{GES}$	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^\circ C$	$\pm 20$	V
$I_c$	Collector current	DC, $T_c = 110^\circ C$	1200	A
		Pulse	(Note 1) 2400	A
$I_E$	Emitter current (Note 2)	DC	1200	A
		Pulse	(Note 1) 2400	A
$I^2t$	Surge current load integral	$T_j = 125^\circ C, V_R = 0V, t_p = 10ms$	—	$KA^2s$
$P_{tot}$	Maximum power dissipation (Note 3)	$T_c = 25^\circ C$ , IGBT part	6750	W
$V_{iso}$	Isolation voltage	RMS, sinusoidal, $f = 60Hz, t = 1min.$	4000	V
$T_{jop}$	Operating junction temperature		$-50 \sim +150$	$^\circ C$
$T_{stg}$	Storage temperature		$-50 \sim +150$	$^\circ C$
$t_{psc}$	Short circuit pulse width	$V_{CC} = 1200V, V_{CE} \leq V_{CES}, V_{GE} = 15V, T_j = 150^\circ C$	10	$\mu s$

**ELECTRICAL CHARACTERISTICS**

Symbol	Item	Conditions	Limits			Unit	
			Min	Typ	Max		
$I_{CES}$	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	$T_j = 25^\circ C$	—	36	—	
			$T_j = 125^\circ C$	—	150	—	
			$T_j = 150^\circ C$	—	180	—	
$V_{GE(th)}$	Gate-emitter threshold voltage	$V_{CE} = 10V, I_c = 120mA, T_j = 25^\circ C$	—	6.0	—	V	
$I_{GES}$	Gate leakage current	$V_{GE} = V_{GES}, V_{CE} = 0V, T_j = 25^\circ C$	-0.5	—	0.5	$\mu A$	
$C_{ies}$	Input capacitance	$V_{CE} = 10V, V_{GE} = 0V, f = 100kHz$ $T_j = 25^\circ C$	—	216	—	nF	
$C_{oes}$	Output capacitance		—	8.0	—	nF	
$C_{res}$	Reverse transfer capacitance		—	1.6	—	nF	
$Q_G$	Total gate charge	$V_{CC} = 850V, I_c = 1200A, V_{GE} = 15V$	—	12.0	—	$\mu C$	
$V_{CEsat}$	Collector-emitter saturation voltage	$I_c = 1200A$ $V_{GE} = 15V$	$T_j = 25^\circ C$	—	1.95	—	
			$T_j = 125^\circ C$	—	2.25	—	
			$T_j = 150^\circ C$	—	2.30	—	
$t_{d(on)}$	Turn-on delay time	$V_{CC} = 850V$ $I_c = 1200A$ $V_{GE} = \pm 15V$ $R_{G(on)} = 1.3\Omega$ $L_s = 100nH$ Inductive load	$T_j = 25^\circ C$	—	0.50	—	
			$T_j = 125^\circ C$	—	0.50	—	
			$T_j = 150^\circ C$	—	0.50	—	
$t_r$	Turn-on rise time		$T_j = 25^\circ C$	—	0.14	—	
			$T_j = 125^\circ C$	—	0.15	—	
			$T_j = 150^\circ C$	—	0.15	—	
$E_{on(10\%)}$	Turn-on switching energy (Note 6)		$T_j = 25^\circ C$	—	110	—	
			$T_j = 125^\circ C$	—	135	—	
			$T_j = 150^\circ C$	—	140	—	
$E_{on}$	Turn-on switching energy (Note 5)		$T_j = 25^\circ C$	—	130	—	
			$T_j = 125^\circ C$	—	155	—	
			$T_j = 150^\circ C$	—	160	—	
$t_{d(off)}$	Turn-off delay time	$V_{CC} = 850V$ $I_c = 1200A$ $V_{GE} = \pm 15V$ $R_{G(off)} = 3.3\Omega$ $L_s = 100nH$ Inductive load	$T_j = 25^\circ C$	—	1.20	—	
			$T_j = 125^\circ C$	—	1.30	—	
			$T_j = 150^\circ C$	—	1.32	—	
$t_f$	Turn-off fall time		$T_j = 25^\circ C$	—	0.12	—	
			$T_j = 125^\circ C$	—	0.15	—	
			$T_j = 150^\circ C$	—	0.17	—	
$E_{off(10\%)}$	Turn-off switching energy (Note 6)		$T_j = 25^\circ C$	—	200	—	
			$T_j = 125^\circ C$	—	280	—	
			$T_j = 150^\circ C$	—	310	—	
$E_{off}$	Turn-off switching energy (Note 5)		$T_j = 25^\circ C$	—	260	—	
			$T_j = 125^\circ C$	—	360	—	
			$T_j = 150^\circ C$	—	400	—	

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## THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit	
			Min	Typ	Max		
V <sub>EC</sub>	Emitter-collector voltage (Note 2)	I <sub>E</sub> = 1200A V <sub>GE</sub> = 0V (Note 4)	T <sub>j</sub> = 25°C	—	1.60	—	
			T <sub>j</sub> = 125°C	—	2.20	—	
			T <sub>j</sub> = 150°C	—	2.30	—	
Q <sub>C</sub>	Total capacitive charge (Note 2,7)	V <sub>CC</sub> = 850V, I <sub>E</sub> = 1200 A R <sub>G(on)</sub> = 1.3Ω, L <sub>s</sub> = 100 nH	T <sub>j</sub> = 25°C	—	5.0	—	
			T <sub>j</sub> = 125°C	—	8.5	—	
			T <sub>j</sub> = 150°C	—	9.0	—	
R <sub>th(j-c)Q</sub>	Thermal resistance	Junction to Case, IGBT part, 1/2 module			—	18.5	K/kW
R <sub>th(j-c)D</sub>		Junction to Case, FWDi part, 1/2 module			—	36.0	K/kW
R <sub>th(c-s)</sub>	Contact thermal resistance	Case to heat sink, 1/2 module λ <sub>grease</sub> = 1W/m·K, D <sub>(c-s)</sub> = 100μm	—	16.0	—	K/kW	

## MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
M <sub>t</sub>	Mounting torque	Main terminals screw	7.0	—	20.0	N·m
M <sub>s</sub>		Mounting screw	3.0	—	6.0	N·m
M <sub>t</sub>		Auxiliary terminals screw	1.0	—	3.0	N·m
m	Mass		—	0.8	—	kg
CTI	Comparative tracking index		600	—	—	—
d <sub>a</sub>	Clearance		9.5	—	—	mm
d <sub>s</sub>	Creepage distance		15.0	—	—	mm
L <sub>P CE</sub>	Parasitic stray inductance	1/2 module	—	30.0	—	nH
R <sub>CC+EE</sub>	Internal lead resistance	T <sub>c</sub> = 25°C, 1/2 module	—	0.28	—	mΩ

Note1. Pulse width and repetition rate should be such that junction temperature (T<sub>j</sub>) does not exceed T<sub>jopmax</sub> rating.

2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).

3. Junction temperature (T<sub>j</sub>) should not exceed T<sub>jmax</sub> rating.

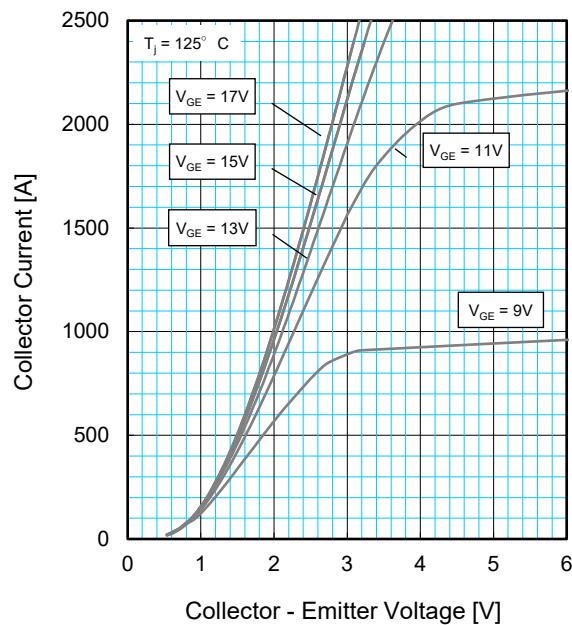
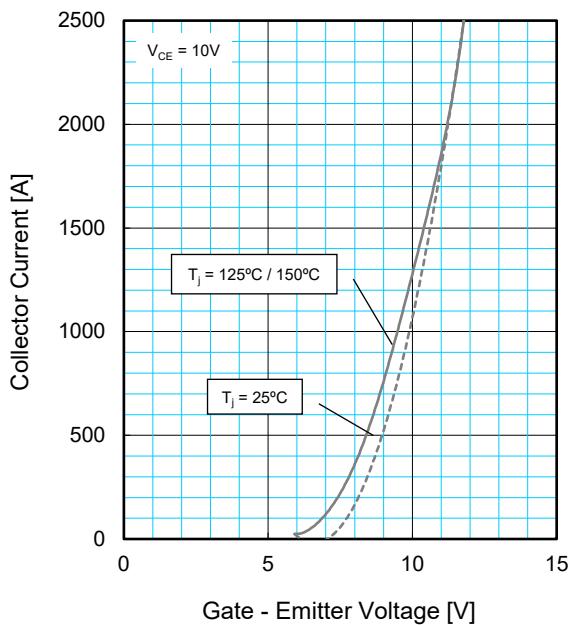
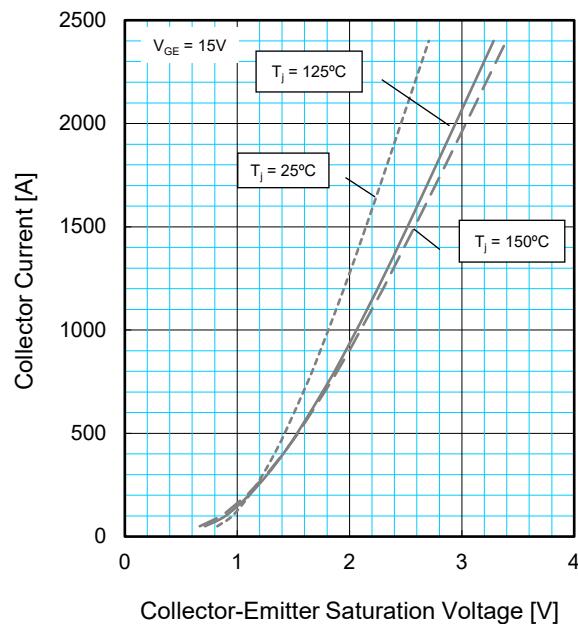
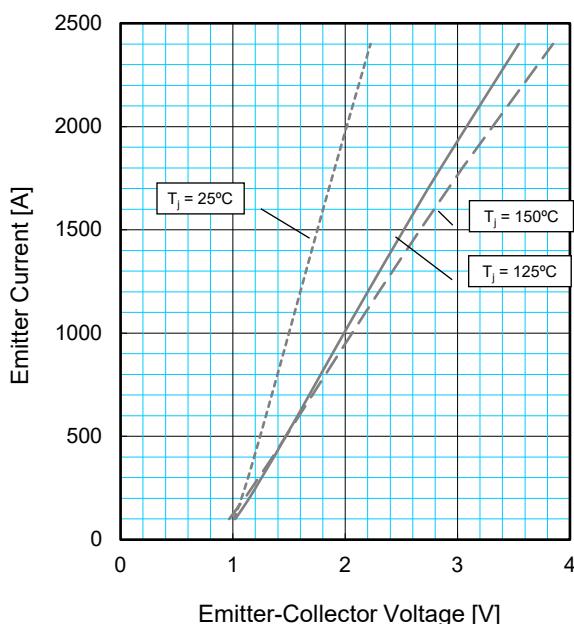
4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

5. Definition of all items is according to IEC 60747, unless otherwise specified.

6. E<sub>on(10%)</sub> / E<sub>off(10%)</sub> / E<sub>rec(10%)</sub> are the integral of 0.1V<sub>CE</sub> x 0.1I<sub>C</sub> x dt.

7. Capacitive charge during anti-paralleled FWDi's turn-off operation.

## PERFORMANCE CURVES

**OUTPUT CHARACTERISTICS  
(TYPICAL)****TRANSFER CHARACTERISTICS  
(TYPICAL)****COLLECTOR-EMITTER SATURATION VOLTAGE  
CHARACTERISTICS (TYPICAL)****FREE-WHEEL DIODE FORWARD  
CHARACTERISTICS (TYPICAL)**

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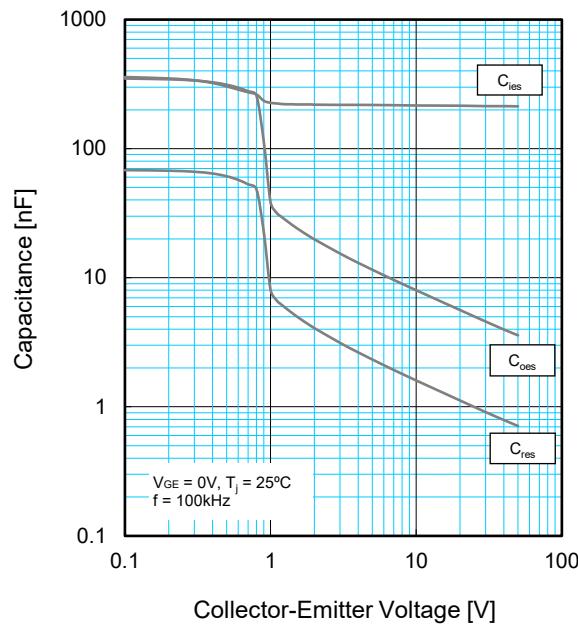
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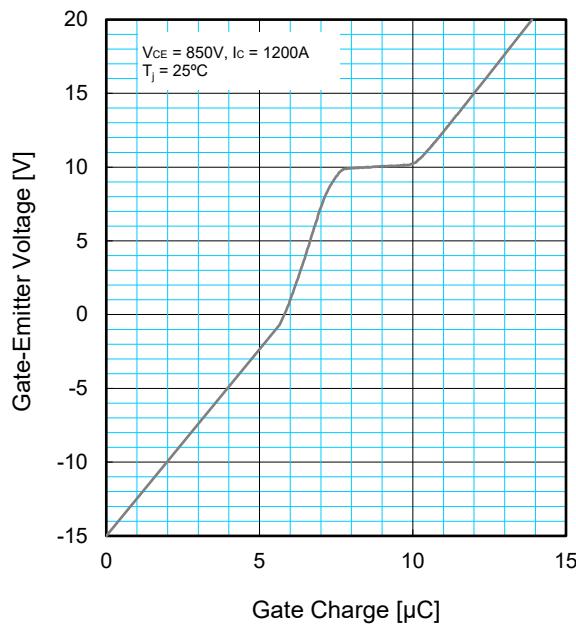
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PERFORMANCE CURVES

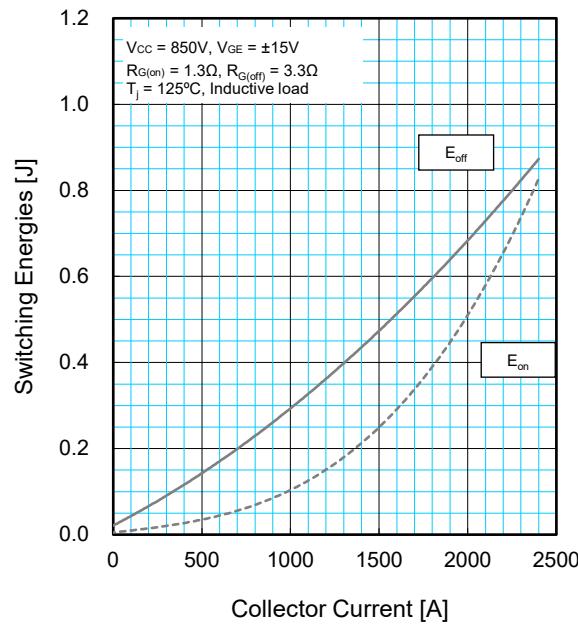
**CAPACITANCE CHARACTERISTICS  
(TYPICAL)**



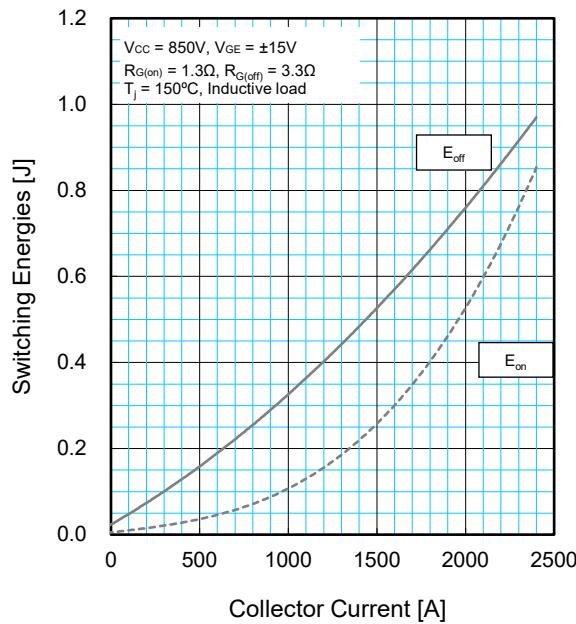
**GATE CHARGE CHARACTERISTICS  
(TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY  
CHARACTERISTICS (TYPICAL)**

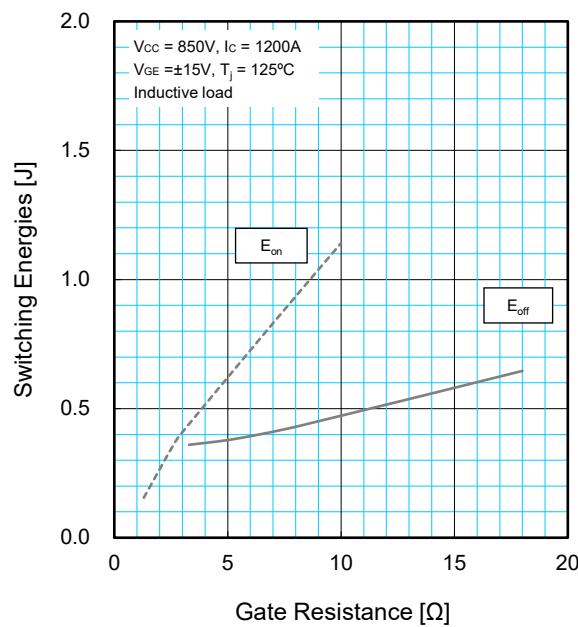


**HALF-BRIDGE SWITCHING ENERGY  
CHARACTERISTICS (TYPICAL)**

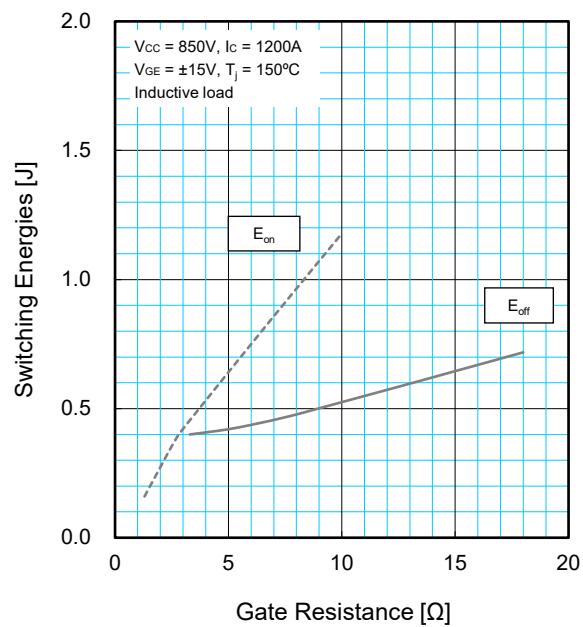


## PERFORMANCE CURVES

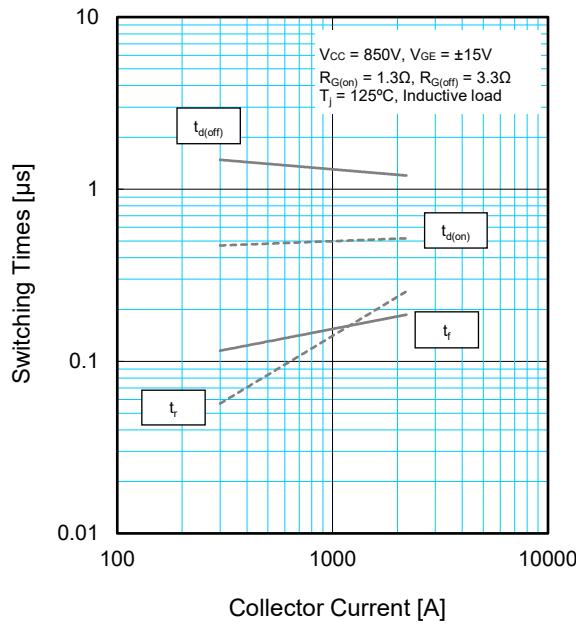
## HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



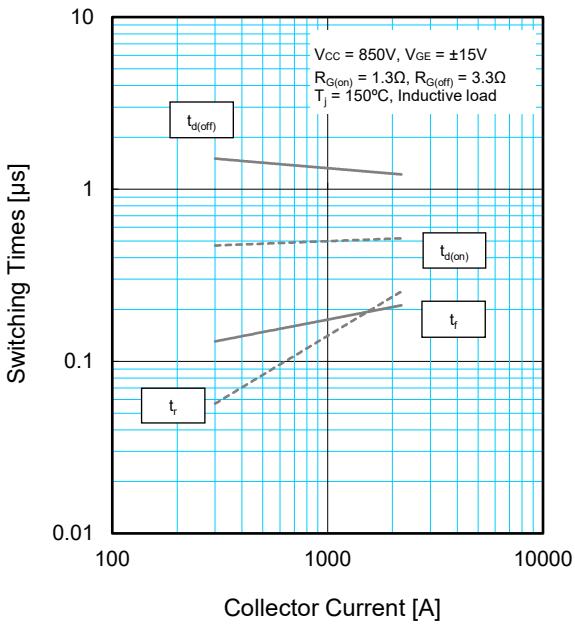
## HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



## HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



## HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)

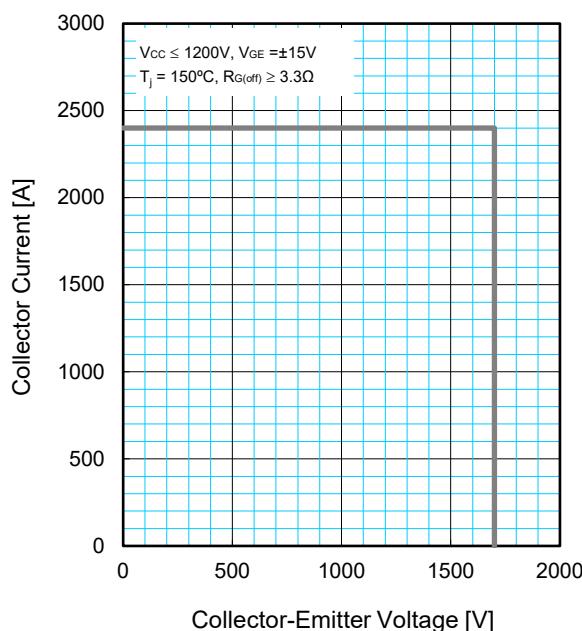


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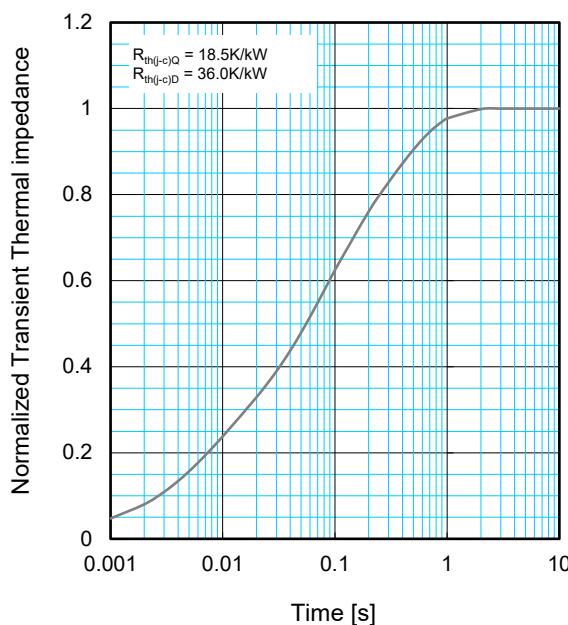
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PERFORMANCE CURVES

**REVERSE BIAS  
SAFE OPERATING AREA (RBSOA)**



**TRANSIENT THERMAL IMPEDANCE  
CHARACTERISTICS**



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp \left( -\frac{t}{\tau_i} \right) \right\}$$

R <sub>i</sub> [K/kW]	1	2	3	4
t [sec]	0.0001	0.0058	0.0602	0.3512

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